

**Search Notes**

Application/Control No.

10/669,566

Examiner

Devin Hanan

Applicant(s)/Patent under  
Reexamination

GURTH, MAX I.

Art Unit

3745

**SEARCHED**

Class	Subclass	Date	Examiner
415	90, 72		
416	175, 176		
	198R, 203	5/20/2005	DH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
consulted Ninh Nguyen on class 415 and 416	5/18/2005	DH